TP65H030G4PQS

650V SuperGaN® GaN FET in TOLL (source tab)

Description

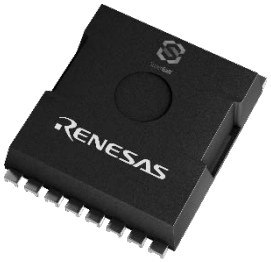
The TP65H030G4PQS 650V, 30mΩ Gallium Nitride (GaN) FET is a normally-off device using Renesas' Gen IV plus platform. It combines a state-of-the-art high voltage GaN HEMT with a low voltage silicon MOSFET to offer superior performance, standard drive, ease of adoption and reliability.

The Gen IV plus SuperGaN® platform uses advanced epi and patented design technologies to simplify manufacturability while improving efficiency over silicon via lower gate charge, output capacitance, crossover loss, and reverse recovery charge.

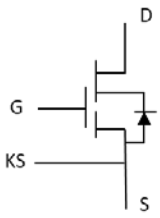
Benefits

- Superior normally off architecture with D-mode GaN HEMT
- Compatible with standard silicon drivers
- Enhanced noise immunity with a 4V threshold voltage with no negative gate drive required
- Enables high-efficiency, high power density, and reliable power conversion
- Facilitates cost-effective GaN adoption, reducing system size, weight, and costs

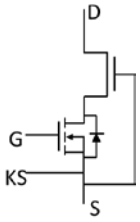
Product and Schematic Diagrams



TP65H030G4PQS TOLL



Cascode Schematic Symbol



Cascode Device Structure

Features

- Ultra-fast switching Gen IV plus GaN
- JEDEC-qualified GaN technology
- Dynamic $R_{DS(on)eff}$ production tested
- Reduced crossover loss
- Negligible Qrr
- RoHS compliant and Halogen-free packaging

Applications

- AI datacenter and telecom power supplies
- E-mobility charging
- PV inverter
- UPS
- BESS

Specifications

V_{DS} (V)	650
$V_{DSS(TR)}$(V) maximum	800
$R_{DS(on)}$ (mΩ) maximum [1]	37
Q_{OSS} (nC) typical	135
Q_G (nC) typical	24.5

1. Dynamic $R_{DS(on)}$ (see Figure 17 and Figure 18)

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1. Pin Information

1.1 Pin Assignments

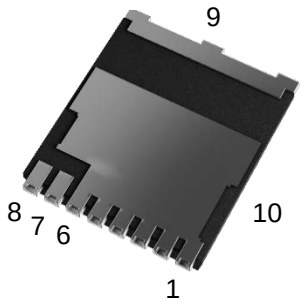


Figure 1. Pin Assignments – Bottom View

1.2 Pin Descriptions

Pin Number	Pin Name	Description
1, 2, 3, 4, 5, 6	S	Source.
7	KS	Kelvin Source.
8	G	Gate.
9	D	Drain.
10	S	Source.

2. Specifications

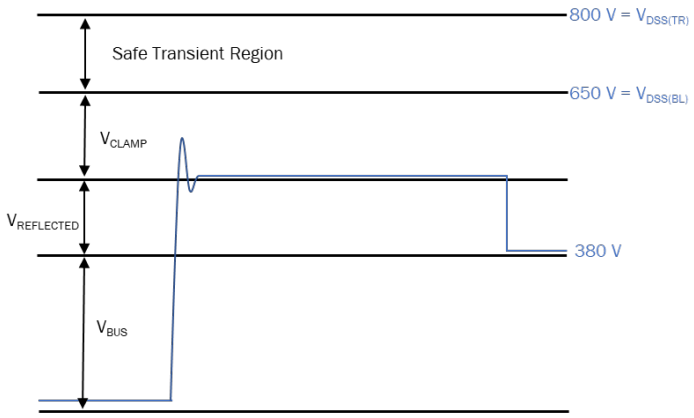
2.1 Absolute Maximum Ratings

T_c = 25°C unless otherwise stated.

Caution: Do not operate at or near the maximum ratings listed for extended periods of time. Exposure to such conditions can adversely impact product reliability and result in failures not covered by warranty.

Symbol	Parameter	Minimum	Maximum	Unit
V_{DSS}	Drain to source voltage (T_J = -55°C to 150°C)	-	650	V
$V_{DSS(TR)}$	Transient drain to source voltage [1]	-	800	
$V_{DSS(TR)\ ,\ pulsed}$	Drain to source voltage, pulsed [2]	-	750	
V_{GSS}	Gate to source voltage	-20	+20	
P_D	Maximum power dissipation at T_C = 25°C	-	192	W
I_D	Continuous drain current at T_C = 25°C	-	55.7	A
	Continuous drain current at T_C = 100°C	-	35	A
I_{DM}	Pulsed drain current (pulse width: 10µs)	-	230	A
T_J	Operating temperature junction	-55	+150	°C
T_S	Storage temperature	-55	+150	°C
T_{SOLD}	Reflow soldering temperature [3]	-	260	°C

1. V_{GS} = 0V, ≤ 10µs, ≤ 1% Duty Cycle, cumulative 60s (60 million pulses).
2. V_{GS} = 0V, ≤1µs, ≤ 1% Duty Cycle, cumulative 10h (36 billion pulses).
3. Reflow MSL3.



Primary Switch Voltage Stress (264 V AC)

2.2 Thermal Specifications

Symbol	Condition	Typical Value	Unit
$R_{\Theta JC}$	Junction-to-case	0.65	°C/W
$R_{\Theta JA}$	Junction-to-ambient	40	

2.3 Electrical Specifications – Forward Device

T_J = 25°C unless otherwise stated.

Symbol	Parameter	Test Conditions	Minimum	Typical	Maximum	Unit
$V_{DSS(BL)}$	Maximum drain-source voltage	V_{GS} = 0V	650	-	-	V
$V_{GS(th)}$	Gate threshold voltage	V_{DS} = V_{GS}, I_D = 1mA	3.3	4	4.8	V
$\Delta V_{GS(th)}/T_J$	Gate threshold voltage temperature coefficient		-	-6.5	-	mV/°C
$R_{DS(on)eff}$	Drain-source on-resistance [1]	V_{GS} = 12V, I_D = 30A, T_J = 25°C	-	30	37	mΩ
		V_{GS} = 12V, I_D = 30A, T_J = 150°C	-	62	-	
I_{DSS}	Drain-to-source leakage current	V_{DS} = 650V, V_{GS} = 0V, T_J = 25°C	-	3	30	µA
		V_{DS} = 650V, V_{GS} = 0V, T_J = 150°C	-	20	-	
I_{GSS}	Gate-to-source forward leakage current	V_{GS} = 20V	-	-	400	nA
	Gate-to-source reverse leakage current	V_{GS} = -20V	-	-	-400	
C_{ISS}	Input capacitance	V_{GS} = 0V, V_{DS} = 400V, *f* = 1MHz	-	1500	-	pF
C_{OSS}	Output capacitance		-	127	-	
C_{RSS}	Reverse transfer capacitance		-	4.6	-	
$C_{O(er)}$	Output capacitance, energy related [2]	V_{GS} = 0V, V_{DS} = 0V to 400V	-	183	-	pF
$C_{O(tr)}$	Output capacitance, time related [3]		-	339	-	
Q_G	Total gate charge	V_{DS} = 400V, V_{GS} = 0V to 12V, I_D = 30A	-	24.5	-	nC
Q_{GS}	Gate-source charge		-	8.4	-	
Q_{GD}	Gate-drain charge		-	6.6	-	
Q_{OSS}	Output charge	V_{GS} = 0V, V_{DS} = 0V to 400V	-	135	-	nC
$t_{D(on)}$	Turn-on delay	V_{DS} = 400V, V_{GS} = 0V to 12V, $R_{G(on)}$ = 10Ω, $R_{G(off)}$ = 30Ω, I_D = 30A, Z_{FB} = 180Ω at 100MHz (see Figure 15)	-	26.4	-	ns
t_R	Rise time		-	6.4	-	
$t_{D(off)}$	Turn-off delay		-	63.6	-	
t_F	Fall time		-	8	-	

1. Dynamic $R_{DS(on)}$ 100% tested; see Figure 17 and Figure 18 for conditions.
2. Equivalent capacitance to give same stored energy from 0V to 400V.
3. Equivalent capacitance to give same charging time from 0V to 400V.

2.4 Electrical Specifications – Reverse Device

T_J = 25°C unless otherwise stated.

Symbol	Parameter	Test Conditions	Minimum	Typical	Maximum	Unit
I_S	Reverse current	V_{GS} = 0V, T_C = 100°C, ≤ 25% duty cycle	-	-	32	A
V_{SD}	Reverse voltage [1]	V_{GS} = 0V, I_S = 32A	-	1.8	-	V
		V_{GS} = 0V, I_S = 16A	-	1.3	-	

1. Includes dynamic $R_{DS(on)}$ effect.

Note: Reverse recovery charge is negligible, enabled by the LV Si FET technology

3. Typical Performance Graphs

T_C = 25°C unless otherwise stated.

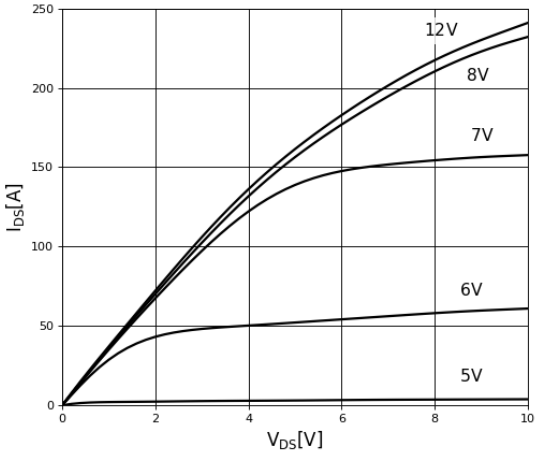


Figure 2. Typical Output Characteristics, T_J = 25°C

Parameter: V_{GS}

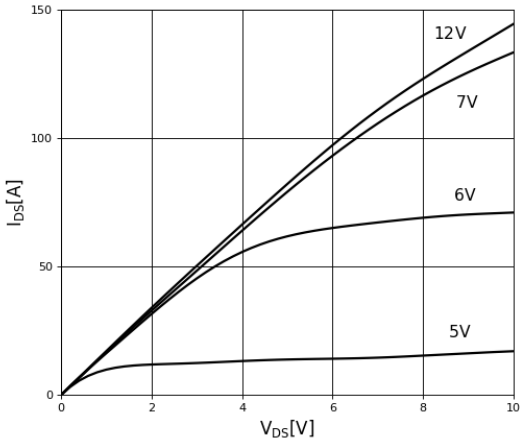


Figure 3. Typical Output Characteristics, T_J = 150°C

Parameter: V_{GS}

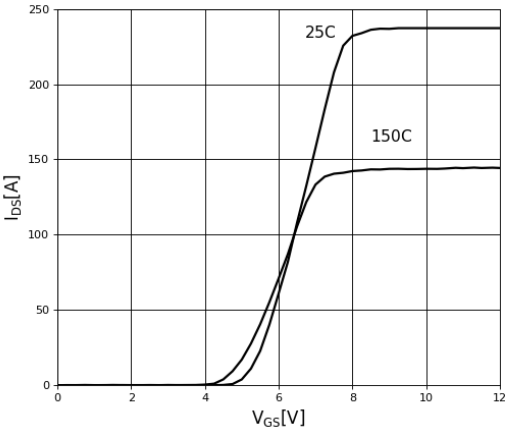


Figure 4. Typical Transfer Characteristics

V_{DS} = 10V, Parameter: T_J

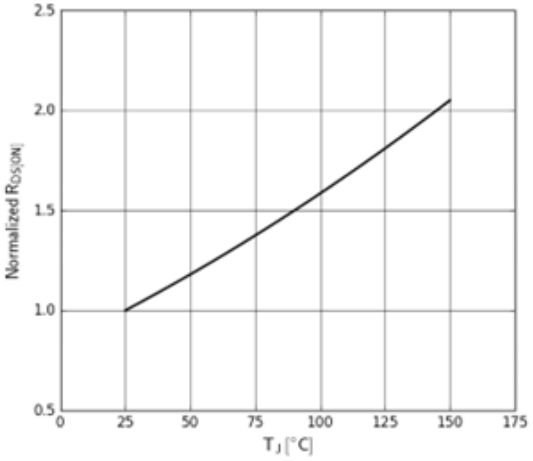


Figure 5. Normalized On-resistance

I_D = 30A, V_{GS} = 12V

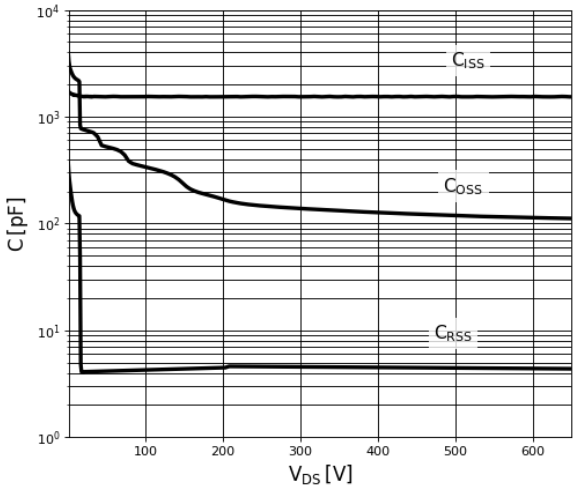


Figure 6. Typical Capacitance

V_{GS} = 0V, f = 1MHz

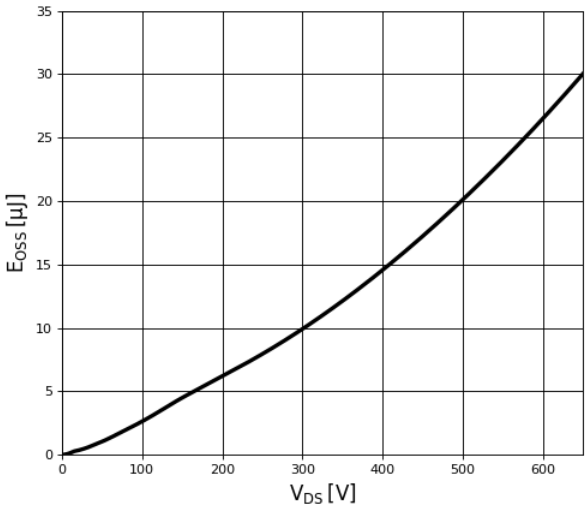


Figure 7. Typical C_{OSS} Stored Energy

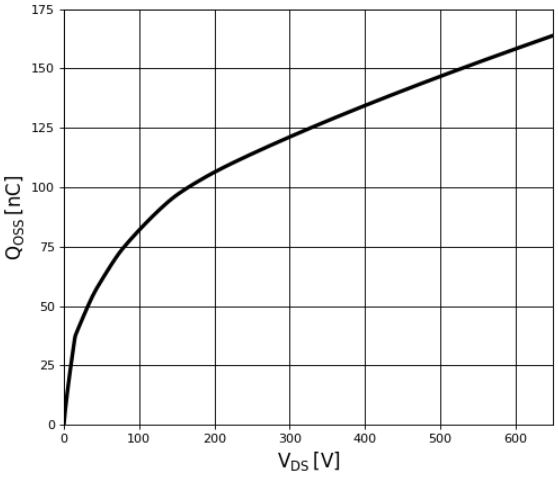


Figure 8. Typical Q_{OSS}

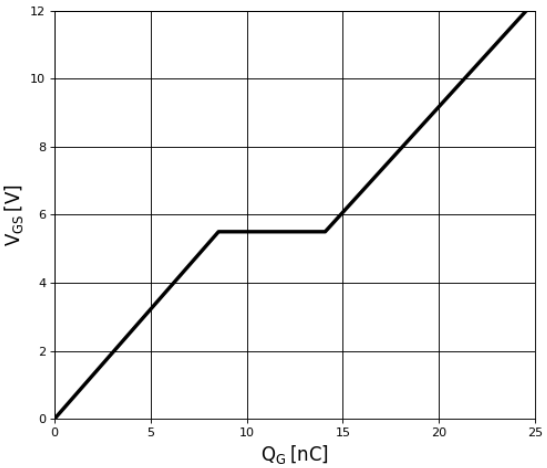


Figure 9. Typical Gate Charge

I_{DS} = 30A, V_{DS} = 400V

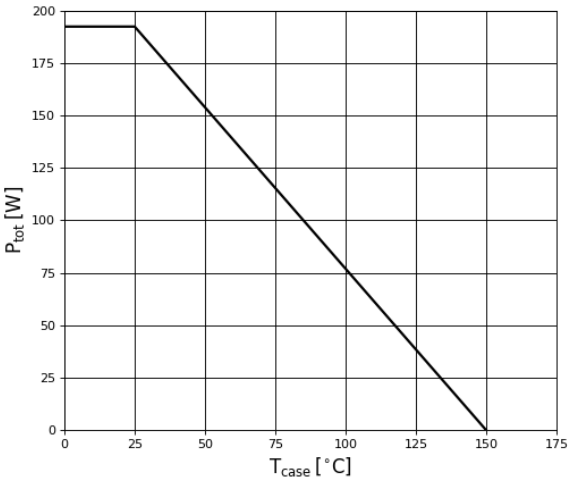


Figure 10. Power Dissipation

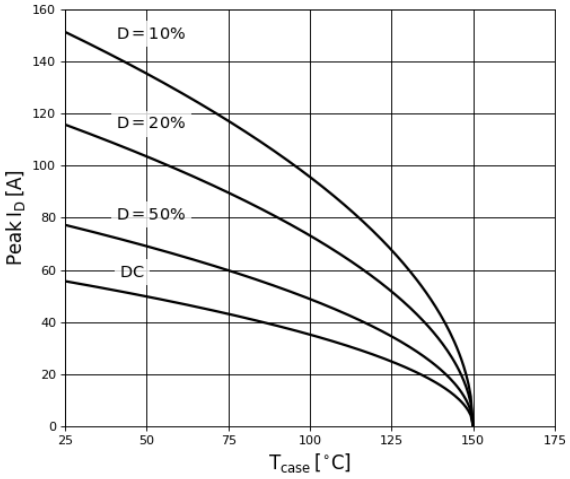


Figure 11. Current Derating

Pulse width ⩽ 10µs, V_{GS} ⩾ 12V

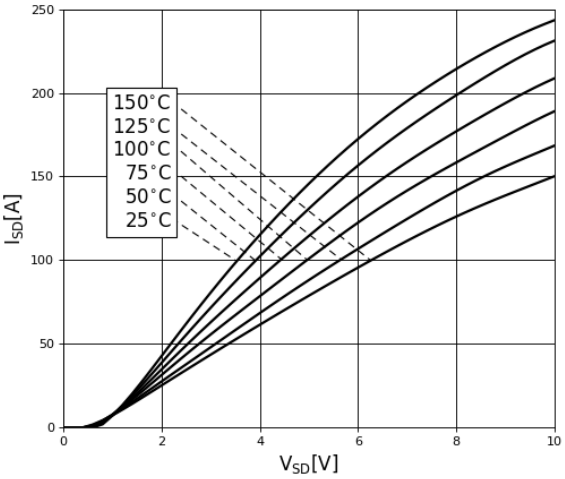


Figure 12. Forward Characteristics of Rev. Diode

$I_S = f(V_{SD})$, Parameter: T_J

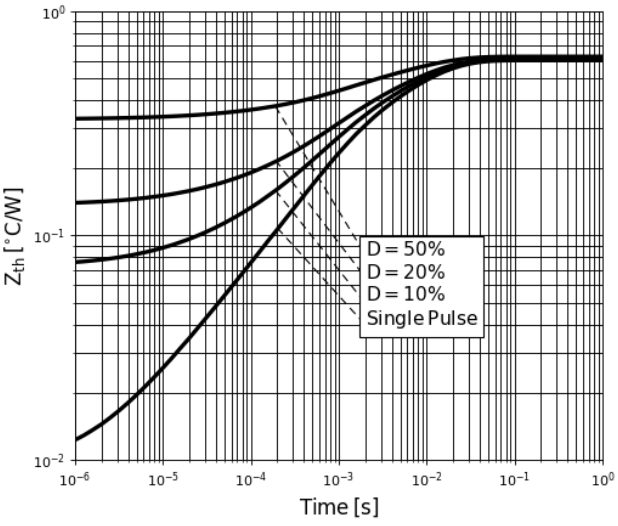


Figure 13. Transient Thermal Resistance

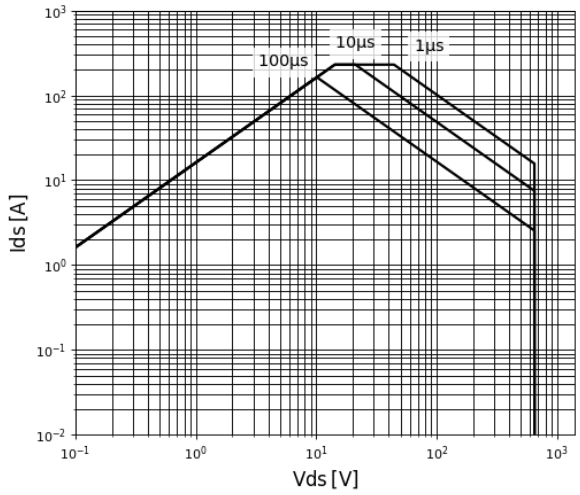


Figure 14. Safe Operating Area T_C = 25°C

4. Test Circuits and Waveforms

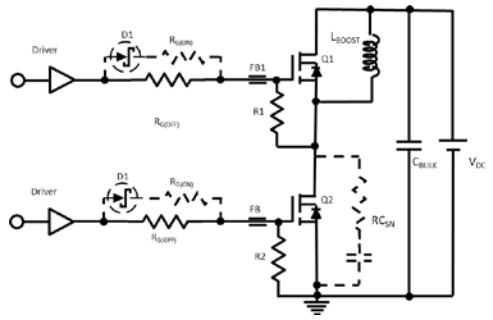


Figure 15. Switching Time Test Circuit

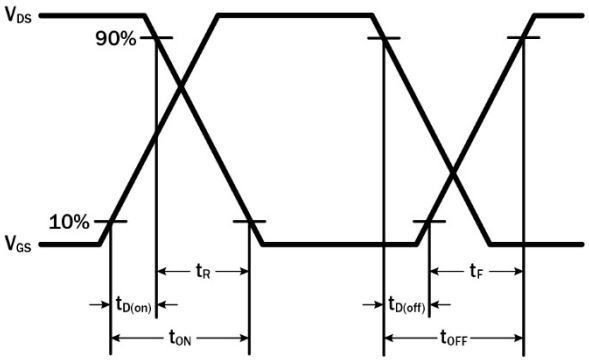


Figure 16. Switching Time Waveform

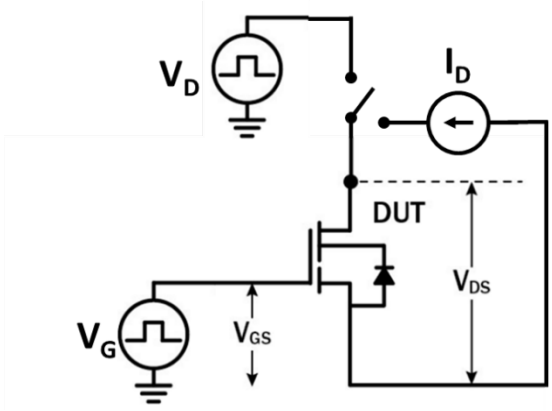


Figure 17. Dynamic $R_{DS(on)eff}$ Test Circuit

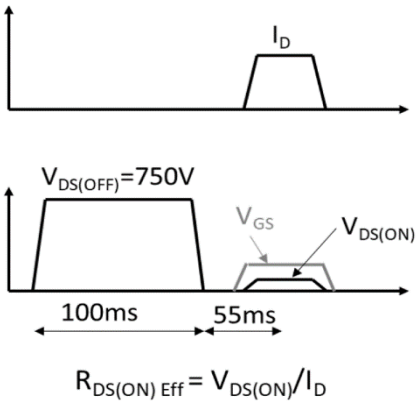
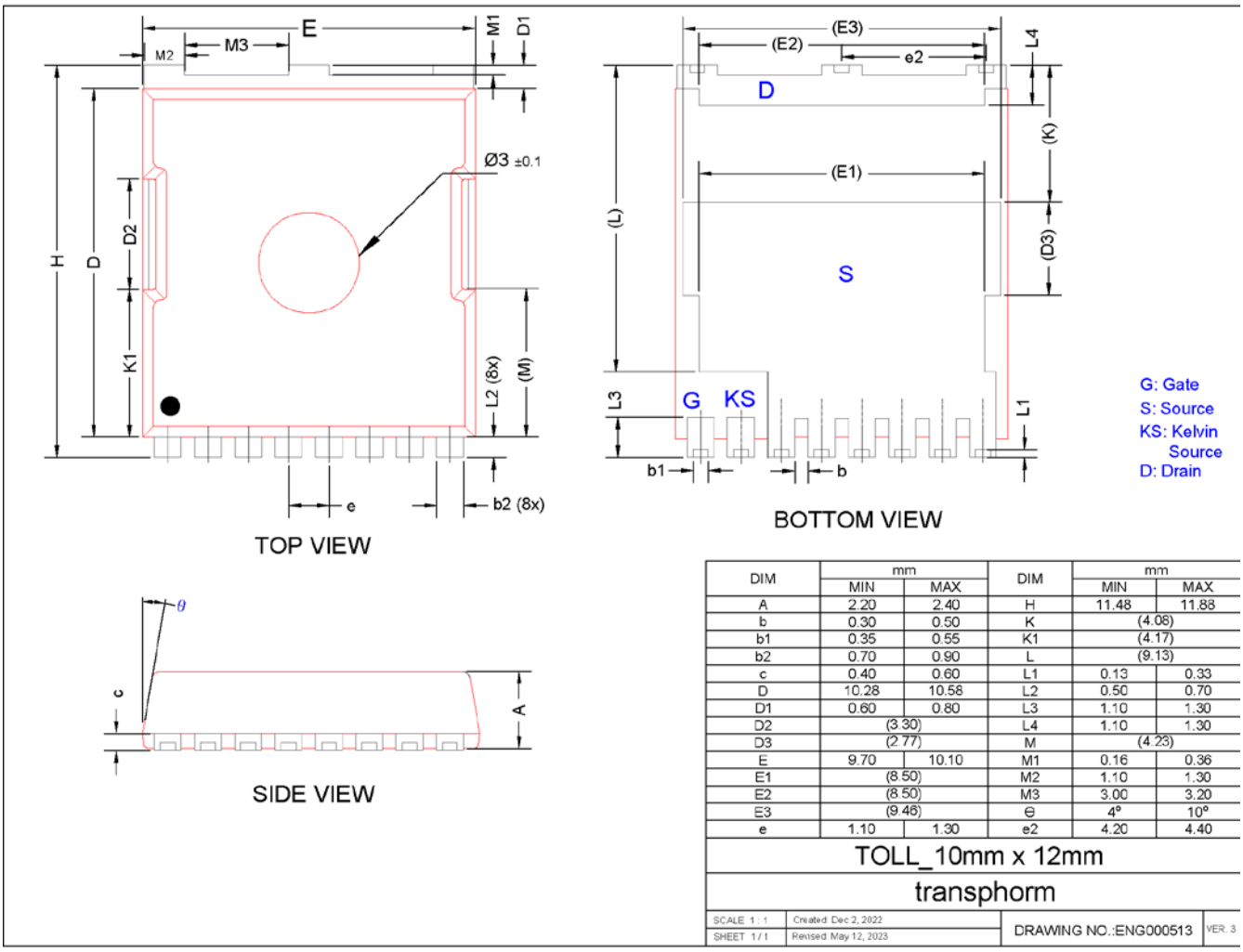


Figure 18. Dynamic $R_{DS(on)eff}$ Waveform

5. Package Outline Drawings



DIM	mm MIN	mm MAX	DIM	mm MIN	mm MAX
A	2.20	2.40	H	11.48	11.88
b	0.30	0.50	K	(4.08)	
b1	0.35	0.55	K1	(4.17)	
b2	0.70	0.90	L	(9.13)	
c	0.40	0.60	L1	0.13	0.33
D	10.28	10.58	L2	0.50	0.70
D1	0.60	0.80	L3	1.10	1.30
D2	(3.30)		L4	1.10	1.30
D3	(2.77)		M	(4.23)	
E	9.70	10.10	M1	0.16	0.36
E1	(8.50)		M2	1.10	1.30
E2	(8.50)		M3	3.00	3.20
E3	(9.46)		θ	4°	10°
e	1.10	1.30	e2	4.20	4.40

TOLL_10mm x 12mm

transphorm

SCALE 1 : 1 | Created: Dec 2, 2022
SHEET 1 / 1 | Revised: May 12, 2023
DRAWING NO.:ENG000513 VER. 3

Figure 19. 10 × 12 mm TOLL Package Outline Drawing

6. Related Information

All technical documents for Renesas GaN Power devices are accessible from the GaN Power Solutions page.

7. Ordering Information

Part Number	Package Description	Package Configuration
TP65H030G4PQS	TOLL	Source tab

8. Revision History

Revision	Date	Description
2.01	June 29, 2026	Updated maximum Rds(on) specification and transient voltage test conditions.
2.00	Nov 25, 2025	Updated the document's formatting; no technical changes were completed.
1.00	May 16, 2025	Initial release.

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